Supporting Information

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1. Synthesis and Characterization of Aligned Pearl-Like Nanotube Arrays

A dense Al_2O_3 buffer layer is first deposited on a Si substrate by the ion-beam-assisted deposition technique, and then the iron layer is coated on the top surface of the buffer layer. The synthesis process was performed in a quartz tube furnace. Forming gas (Ar with 6% H₂) was used as the carrier gas, and pure ethanol served as the carbon source. In a typical synthesis, nanotube growth was carried out between 800 and 850 °C. Arrays with thickness up to hundreds of micrometer can be prepared by this approach.



Figure S1. SEM on the top surface of carbon nanotube arrays.



Figure S2. X-ray diffraction patterns of the nanotube arrays with different X-ray incidence directions. (a) X-ray strikes the top surface. (b) X-ray strikes the sideway of arrays.



Figure S3. Cross-sectional view of a pearl-like nanotube by high resolution TEM.

2. Conduction Dimensionality of the Pearl-Like Nanotube Fibers

In more detail, the relationship between conductivity and temperature in Mott's hopping model can also be expressed as $\sigma \propto \exp(-A/T^{[1/(d+1)]})$, where A is a constant and d is the dimensionality.¹ The plot of $\ln \sigma$ vs. $T^{-1/4}$ (for d=3), $T^{-1/3}$ (for d=2) and $T^{-1/2}$ (for d=1) have linear fitting coefficients of 0.990, 0.978, and 0.951, respectively (Figure S4–S6). The result suggests that the electron transport is consistent with a 3D hopping mechanism.



Figure S4. The plot of $\ln \sigma$ vs. $T^{-1/2}$ based on the Mott's variable range hopping model as $\sigma \propto \exp(-A/T^{[1/(d+1)]})$, where σ is the electrical conductivity, A is a constant, T is the temperature, and d is the dimensionality. For this plot, d=1, i.e. one-dimension hopping mechanism.



Figure S5. The plot of $\ln \sigma$ vs. T^{-1/3} based on the Mott's variable range hopping model as $\sigma \propto \exp(-A/T^{[1/(d+1)]})$, where σ is the electrical conductivity, A is a constant, T is the temperature, and d is the dimensionality. For this plot, d=2, i.e. two-dimension hopping mechanism.



Figure S6. The plot of $\ln \sigma$ vs. T^{-1/4} based on the Mott's variable range hopping model as $\sigma \propto \exp(-A/T^{[1/(d+1)]})$, where σ is the electrical conductivity, A is a constant, T is the temperature, and d is the dimensionality. For this plot, d=3, i.e. three-dimension hopping mechanism.

Full list of references:

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